


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/084,311	SARUWATARI, EIJI	
	Examiner	Art Unit	
	Jacob Meek	2637	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
375		227			375	317			
INTERNATIONAL CLASSIFICATION					398	26	27	38	
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Jacob Meek 3/22/06 (Assistant Examiner) (Date)	MOHAMMED GHAYOUR SUPERVISORY PATENT EXAMINER <i>M. Gh</i> 3/29/06 (Primary Examiner) (Date)	Total Claims Allowed: 18				
<i>Al-Sawaf</i> 3/30/06 (Legal Instruments Examiner) (Date)		<table border="1"> <tr> <td>O.G. Print Claim(s)</td> <td>O.G. Print Fig.</td> </tr> <tr> <td>1</td> <td>5</td> </tr> </table>	O.G. Print Claim(s)	O.G. Print Fig.	1	5
O.G. Print Claim(s)	O.G. Print Fig.					
1	5					

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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